

UTC UNISONIC TECHNOLOGIES CO., LTD

1NM60

Power MOSFET

1.0A, 600V N-CHANNEL SUPER-JUNCTION MOSFET

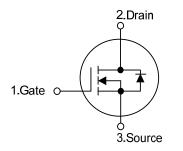
DESCRIPTION

The UTC 1NM60 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

FEATURES

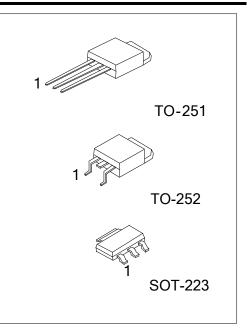
- * R_{DS(ON)} < 3.5Ω @ V_{GS} = 10V, I_D =0.5A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



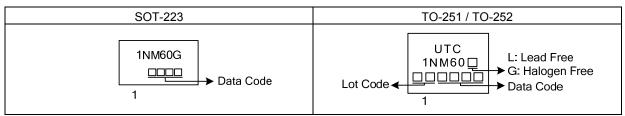
ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment			Deaking		
Lead Free	Halogen Free	Package	1	2	3	Packing		
-	1NM60G-AA3-R	SOT-223	G	D	S	Tape Reel		
1NM60L-TM3-T	1NM60G-TM3-T	TO-251	G	D	S	Tube		
1NM60L-TN3-R	1NM60G-TN3-R	TO-252	G	D	S	Tape Reel		
Note: Pin Assignment: G: Gate D: Drain S: Source								
1NM60G-AA3-R (1)Packing Type (2)Package Type (3)Green Package		 (1) R: Tape Reel, T: Tube (2) AA3: SOT-223, TM3: TO-251, TN3: TO-252 (3) L: Lead Free, G: Halogen Free and Lead Free 						



1NM60

MARKING





■ **ABSOLUTE MAXIMUM RATINGS** (T_c=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	600	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous	I _D	1.0	А
	Pulsed (Note 2)	I _{DM}	4.0	А
Avalanche Current (Note 2)		I _{AR}	1.3	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	8.5	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	6.0	V/ns
Power Dissipation	SOT-223	P _D	8.0	W
	TO-251/TO-252		28	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L=10mH, I_{AS}=1.3A, V_{DD}=50V, R_G=25 Ω , Starting T_J = 25°C

4. $I_{SD} \leq 1.0A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	SOT-223	0	150	°C/W	
	TO-251/TO-252	θ_{JA}	110	°C/W	
Junction to Case	SOT-223	0	15.6	°C/W	
	TO-251/TO-252	θ _{JC}	4.46	°C/W	



■ ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise specified)

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SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV _{DSS}	V _{GS} = 0V, I _D = 250µA				V
I _{DSS}	$V_{DS} = 600V, V_{GS} = 0V$			10	μA
1	V_{GS} = +30V, V_{DS} = 0V			+100	nA
erse	V_{GS} = -30V, V_{DS} = 0V			-100	nA
					-
V _{GS(TH)}	V_{DS} = V_{GS} , I_D = 250 μ A			4.5	V
R _{DS(ON)}	V _{GS} = 10V, I _D =0.5A			3.5	Ω
CISS			113		рF
C _{OSS}	V _{GS} =0V, V _{DS} =25V, f =1MHz		79		рF
C _{RSS}			8.5		рF
Q_{G}			22.5		nC
Q_{GS}			2.3		nC
Q_{GD}			3.7		nC
t _{D (ON)}			43		ns
t _R	V_{DD} =30V, V_{GS} =10V, I_D =0.5A,		40		ns
$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		68		ns
t _F			26		ns
ARACTERISTI	CS				
ls				1.0	Α
I _{SM}				4.0	Α
V _{SD}	I _S =1.0A, V _{GS} =0V			1.4	V
t _{rr}	I _S =1.0A, V _{GS} =0V, dI _F /dt=100A/µs		155		nS
Qrr			0.6		μC
	$\frac{BV_{DSS}}{I_{DSS}}$ $\frac{I_{GSS}}{I_{GSS}}$ $\frac{V_{GS(TH)}}{R_{DS(ON)}}$ $\frac{C_{ISS}}{C_{OSS}}$ $\frac{Q_{G}}{Q_{GS}}$ $\frac{Q_{G}}{Q_{GD}}$ $\frac{t_{D(OFF)}}{t_{F}}$ $\frac{t_{D(OFF)}}{t_{F}}$ $\frac{I_{SM}}{I_{SM}}$ $\frac{V_{SD}}{t_{rr}}$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $

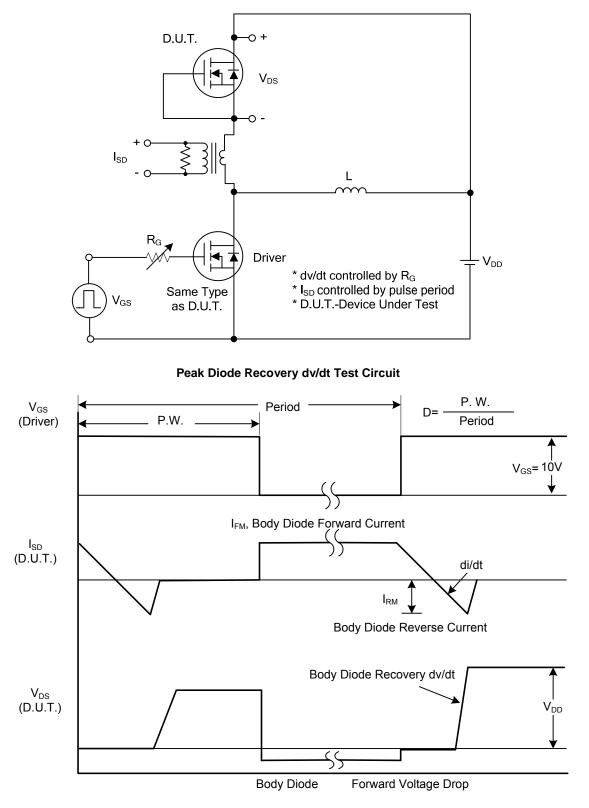
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

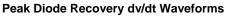
2. Essentially independent of operating temperature.



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TEST CIRCUITS AND WAVEFORMS

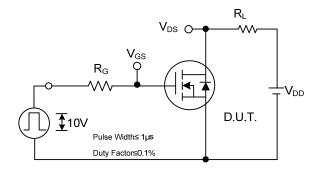


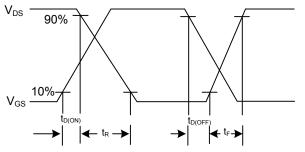




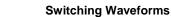
1NM60

■ TEST CIRCUITS AND WAVEFORMS (Cont.)





Switching Test Circuit



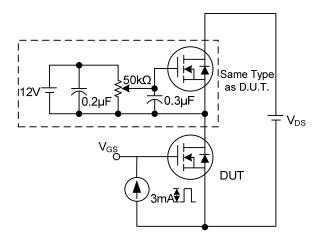
 Q_G

 Q_{GD}

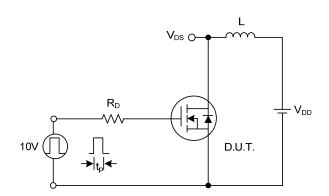
 V_{GS}

10V

Q_{GS}



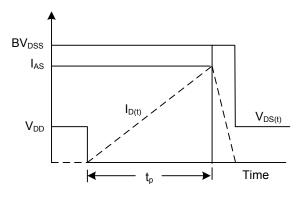
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit

Gate Charge Waveform

Charge



Unclamped Inductive Switching Waveforms



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